

Issue Classification			Application/Control No.		Applicant(s)/Patent under Reexamination	
			09/725,674		HIRANO ET AL.	
			Examiner		Art Unit	
			Minh Dieu Nguyen		2137	

ISSUE CLASSIFICATION					
ORIGINAL		CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)		
713	176	705	51		
INTERNATIONAL CLASSIFICATION		713	201		
H	0	4	L	9/00	
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<i>Minh Dieu Nguyen 6/10/05</i> (Assistant Examiner) (Date)				<i>Andrew Caldwell</i> ANDREW CALDWELL SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) <i>6-28-05</i>	
<i>Eric K. L. Lee</i> (Legal Instruments Examiner) (Date)				Total Claims Allowed: 17 O.G. Print Claim(s) 1 O.G. Print Fig. 5	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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